Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/080,086	LEI ET AL.
Examiner	Art Unit
Jungwon Chang	2154

SEARCHED				
Class	Subclass	Date	Examiner	
705	40 26	10/13/2006	JWC	
709	201	10/13/2006	JWC	
455	414.1	10/13/2006	JWC	

INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARCH I (INCLUDING SEAR		
	DATE EXM	R
East search report attached	10/13/2006 JWC	>
Inventor name searched	10/13/2006 JWG	>